International Rectifier

- Generation V Technology
- Ultra Low On-Resistance
- Dual P-Channel Mosfet
- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Fast Switching
- Lead-Free

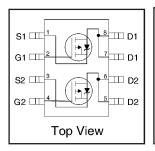
Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.

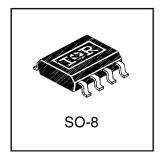
IRF7306PbF

HEXFET® Power MOSFET



$$V_{DSS} = -30V$$

$$R_{DS(on)} = 0.10\Omega$$



Absolute Maximum Ratings

	Parameter	Max.	Units	
I _D @ T _A = 25°C	10 Sec. Pulsed Drain Current, V _{GS} @ -10V	-4.0		
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ -10V	-3.6	١ , ١	
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ -10V	-2.9	_ A	
I _{DM}	Pulsed Drain Current ①	-14		
P _D @T _A = 25°C	Power Dissipation	2.0	W	
	Linear Derating Factor	0.016	W/°C	
V_{GS}	Gate-to-Source Voltage	±20	V	
dv/dt	Peak Diode Recovery dv/dt ②	-5.0	V/ns	
$T_{J,}T_{STG}$	Junction and Storage Temperature Range	-55 to + 150	°C	

Thermal Resistance Ratings

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient⊕		62.5	°C/W

IRF7306PbF

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	-30			V	$V_{GS} = 0V$, ID = -250 μ A
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.037		V/°C	Reference to 25°C, I _D = -1mA
В	Static Drain-to-Source On-Resistance			0.10		$V_{GS} = -10V, I_D = -1.8A$ ③
R _{DS(ON)}	Static Drain-to-Source On-Resistance			0.16	Ω	V _{GS} = -4.5V, I _D = -1.5A ③
V _{GS(th)}	Gate Threshold Voltage	-1.0			V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
g fs	Forward Transconductance	2.5			S	$V_{DS} = -24V, I_{D} = -1.8A$
	Drain to Course Leakage Current			-1.0		$V_{DS} = -24V, V_{GS} = 0V$
IDSS	Drain-to-Source Leakage Current			-25	μA	$V_{DS} = -24V$, $V_{GS} = 0V$, $T_{J} = 125$ °C
I _{GSS}	Gate-to-Source Forward Leakage			-100	nA	$V_{GS} = -20V$
IGSS	Gate-to-Source Reverse Leakage			100	IIA	V _{GS} = 20V
Qg	Total Gate Charge			25		I _D = -1.8A
Q_{gs}	Gate-to-Source Charge			2.9	nC	$V_{DS} = -24V$
Q_{gd}	Gate-to-Drain ("Miller") Charge			9.0		V_{GS} = -10V, See Fig. 6 and 12 ③
t _{d(on)}	Turn-On Delay Time		11			V _{DD} = -15V
t _r	Rise Time		17		20	$I_D = -1.8A$
t _{d(off)}	Turn-Off Delay Time		25		ns	$R_G = 6.0\Omega$
t _f	FallTime		18			R_D = 8.2 Ω , See Fig. 10 ③
L _D	Internal Drain Inductance		4.0		nН	Between lead tip
L _S	Internal Source Inductance		6.0			and center of die contact
C _{iss}	Input Capacitance		440			$V_{GS} = 0V$
Coss	Output Capacitance		200		pF	$V_{DS} = -25V$
C _{rss}	Reverse Transfer Capacitance		93			f = 1.0MHz, See Fig. 5

Source-Drain Ratings and Characteristics

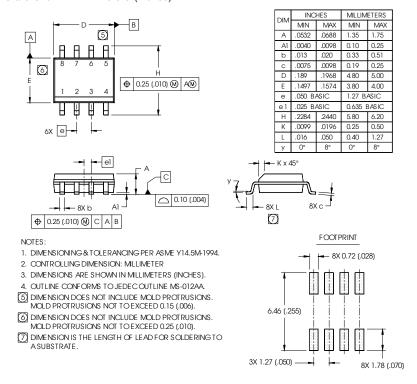
	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current		0.5	_	MOSFET symbol		
	(Body Diode)			-2.5	7.5 A	showing the	
I _{SM}	Pulsed Source Current				4.4	A	integral reverse
	(Body Diode) ①			14		p-n junction diode.	
V _{SD}	Diode Forward Voltage			-1.0	V	$T_J = 25$ °C, $I_S = -1.8$ A, $V_{GS} = 0$ V ③	
t _{rr}	Reverse Recovery Time		53	80	ns	$T_J = 25^{\circ}C, I_F = -1.8A$	
Q_{rr}	Reverse RecoveryCharge		66	99	nC	di/dt = 100A/µs ③	
t _{on}	Forward Turn-On Time	Intr	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)				

Notes:

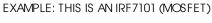
- $\begin{tabular}{ll} @ & I_{SD} \le -1.8A, & di/dt \le 90A/\mu s, & V_{DD} \le V_{(BR)DSS}, \\ & T_{J} \le 150 ^{\circ} C \end{tabular}$

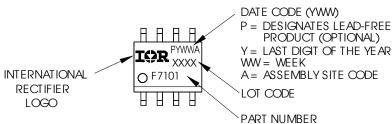
SO-8 Package Outline

Dimensions are shown in milimeters (inches)



SO-8 Part Marking Information (Lead-Free)

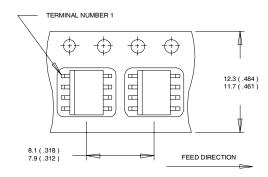




IRF7306PbF

SO-8 Tape and Reel

Dimensions are shown in milimeters (inches)



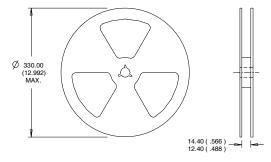
NOTES:

- NO IES:

 1. CONTROLLING DIMENSION: MILLIMETER.

 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).

 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- CONTROLLING DIMENSION : MILLIMETER.
 OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice. This product has been designed and qualified for the Consumer market. Qualifications Standards can be found on IR's Web site.

International IOR Rectifier